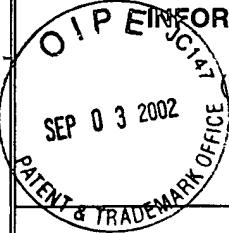


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U.S. PATENT DOCUMENTS													
EXAMINER INITIAL		DOCUMENT NUMBER						DATE	NAME		CLASS	SUB-CLASS	FILING DATE IF APPROPRIATE
TT		5	9	7	6	9	2	0	11/2/99	Kenichi Nakano, et al.	—	—	
TT		6	2	1	7	2	1	0	4/17/01	Robert S. Roeder, et al.	—	—	
FOREIGN PATENT DOCUMENTS													
		DOCUMENT NUMBER						DATE	COUNTRY		CLASS	SUB-CLASS	TRANSLATION
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)													
TT		Ramakrishna, S., et al., <i>HEMT Modelling Using Semi-Physical Expressions for the Equilibrium Space-Charge Parameters of the Modulation-Doped Heterojunction</i> , IEEE, August 1999, pgs. 211-214.											
TT		Winson, Peter B., et al., <i>A Table Based Bias and Temperature Dependent Small Signal and Noise Equivalent Circuit Model</i> , IEEE, May 1995, pgs. 623-626, entire document.											
TT		Karmalkar, Shreepad, et al., <i>A Simple Yet Comprehensive Unified Physical Model of the 2-D Electron Gas in Delta-Doped and Uniformly Doped High Electron Mobility Transistors</i> , IEEE, Vol. 47, No. 1, January 2000, pgs. 11-23.											
TT		Francois Danneville, et al., <i>Noise Modeling in MESFET and HEMT Mixers Using a Uniform Noisy Line Model</i> , IEEE, Vol. 45, No. 10, October 1998, pgs. 2207-2212.											
TT		Ranjit Singh, et al., <i>Small-Signal Characterization of Microwave and Millimeter-Wave HEMT's Based on a Physical Model</i> , IEEE, Vol. 44, No. 1, January 1996, pgs. 114-121.											
EXAMINER								DATE CONSIDERED		12-11-02			
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